

TECHNICAL SPEC FOR Measurement system

System Model:

ADE 9350, serial number 9300-0107

Wafer size: 6 inch

Wafer types:Jeida flat

Send/receive elevators: 2

Cassette to cassette: Yes

Prealigner station: Yes

Resistivity test: yes

Dopant typing:

Non-Contact Capacitive Probe Measurement:

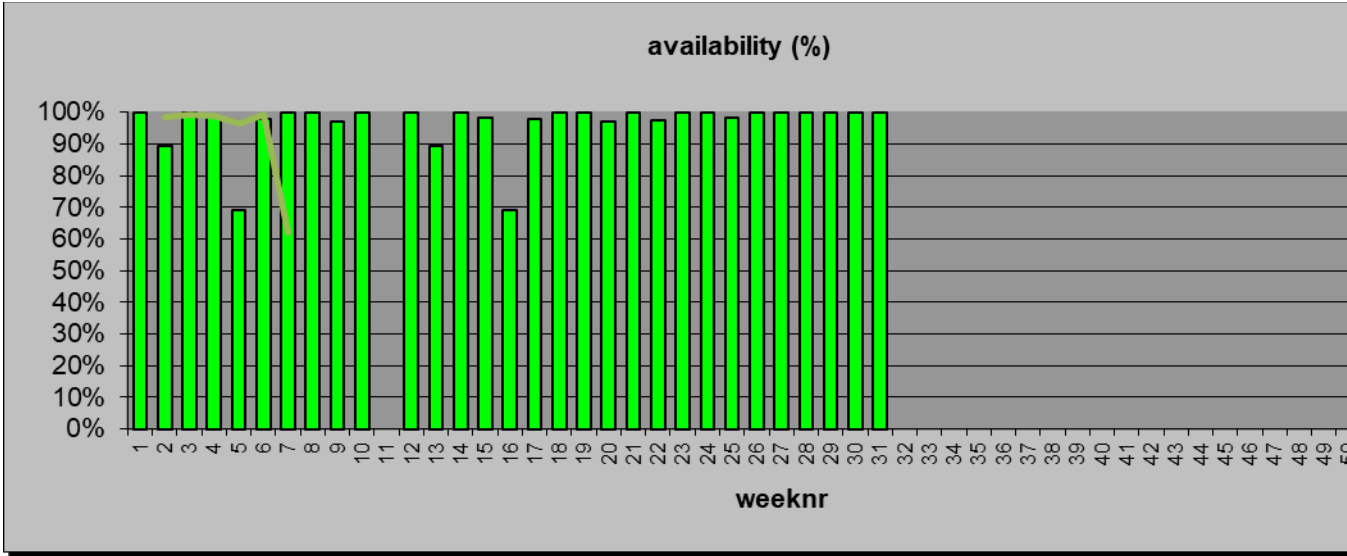
Wafer Thickness Range: 650 um

Vintage: 1993

Missing parts: none

Defected parts: none

Availability 2024:



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(if any)